

T-39-13

**MOTOROLA
SEMICONDUCTOR**
TECHNICAL DATA

Designer's Data Sheet
Power Field Effect Transistor
N-Channel Enhancement-Mode
Silicon Gate TMOS

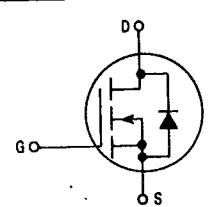
These TMOS Power FETs are designed for high voltage, high speed power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds — Switching Times Specified at 100°C
- Designer's Data — I_{DSS} , $V_{DS(on)}$, $V_{GS(th)}$ and SOA Specified at Elevated Temperature
- Rugged — SOA is Power Dissipation Limited
- Source-to-Drain Diode Characterized for Use With Inductive Loads



**MTH8N55
MTH8N60
MTM8N60**

TMOS POWER FETs
8 AMPERES
 $r_{DS(on)} = 0.5 \text{ OHM}$
550 and 600 VOLTS



MAXIMUM RATINGS

| Rating | Symbol | MTH8N55 | MTH8N60 MTM8N60 | Unit |
|---|-----------------------|----------------------|--------------------|------------------------------|
| Drain-Source Voltage | V_{DSS} | 550 | 600 | Vdc |
| Drain-Gate Voltage ($R_{GS} = 1 \text{ M}\Omega$) | V_{DGR} | 550 | 600 | Vdc |
| Gate-Source Voltage Continuous Non-repetitive ($t_p \leq 50 \mu\text{s}$) | V_{GS} V_{GSM} | ± 20 ± 40 | | Vdc Vpk |
| Drain Current — Continuous — Pulsed | I_D I_{DM} | 8 41 | | Adc |
| Total Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate above 25°C | P_D | 150 1.2. | | Watts W/ $^\circ\text{C}$ |
| Operating and Storage Temperature Range | T_J, T_{stg} | -65 to 150 | | °C |

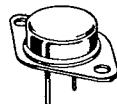
THERMAL CHARACTERISTICS

| | | | |
|--|------------------------------------|------------|------|
| Thermal Resistance — Junction to Case — Junction to Ambient | $R_{\theta JC}$ $R_{\theta JA}$ | 0.83 30 | °C/W |
| Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 5 seconds | T_L | 275 | °C |

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise noted)

| Characteristic | Symbol | Min | Max | Unit |
|---|---------------|------------|----------|------|
| OFF CHARACTERISTICS | | | | |
| Drain-Source Breakdown Voltage ($V_{GS} = 0$, $I_D = 0.25 \text{ mA}$) MTH8N55 MTH8N60, MTM8N60 | $V_{(BR)DSS}$ | 550 600 | — | Vdc |
| Zero Gate Voltage Drain Current ($V_{DS} = \text{Rated } V_{DSS}$, $V_{GS} = 0$) ($V_{DS} = 0.8 \text{ Rated } V_{DSS}$, $V_{GS} = 0$, $T_J = 125^\circ\text{C}$) | I_{DSS} | — — | 0.2 1 | mAdc |

(continued)



MTM8N60
CASE 1-06
TO-204AA



**MTH8N55
MTH8N60**
CASE 340-02
TO-218AC

Designer's Data for "Worst Case" Conditions — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

ELECTRICAL CHARACTERISTICS -- continued ($T_C = 25^\circ\text{C}$ unless otherwise noted)

| Characteristic | Symbol | Min | Max | Unit |
|----------------|--------|-----|-----|------|
|----------------|--------|-----|-----|------|

OFF CHARACTERISTICS

| | | | | |
|--|------------|---|-----|------|
| Gate-Body Leakage Current, Forward ($V_{GSF} = 20 \text{ Vdc}, V_{DS} = 0$) | I_{GSSF} | — | 100 | nAdc |
| Gate-Body Leakage Current, Reverse ($V_{GSR} = 20 \text{ Vdc}, V_{DS} = 0$) | I_{GSSR} | — | 100 | nAdc |

ON CHARACTERISTICS*

| | | | | |
|--|---------------------|----------|----------|------|
| Gate Threshold Voltage ($V_{DS} = V_{GS}, I_D = 1 \text{ mA}$) $T_J = 100^\circ\text{C}$ | $V_{GS(\text{th})}$ | 2 1.5 | 4.5 4 | Vdc |
| Static Drain-Source On-Resistance ($V_{GS} = 10 \text{ Vdc}, I_D = 4 \text{ Adc}$) | $r_{DS(\text{on})}$ | — | 0.5 | Ohm |
| Drain-Source On-Voltage ($V_{GS} = 10 \text{ V}$) ($I_D = 8 \text{ Adc}$) ($I_D = 4 \text{ Adc}, T_J = 100^\circ\text{C}$) | $V_{DS(\text{on})}$ | — — | 5 4 | Vdc |
| Forward Transconductance ($V_{DS} = 10 \text{ V}, I_D = 4 \text{ A}$) | g_{FS} | 4 | — | mhos |

DYNAMIC CHARACTERISTICS

| | | | | | |
|------------------------------|--|-----------|---|------|----|
| Input Capacitance | $(V_{DS} = 25 \text{ V}, V_{GS} = 0,$ $f = 1 \text{ MHz})$ See Figure 11 | C_{iss} | — | 2300 | pF |
| Output Capacitance | | C_{oss} | — | 425 | |
| Reverse Transfer Capacitance | | C_{rss} | — | 180 | |

SWITCHING CHARACTERISTICS* ($T_J = 100^\circ\text{C}$)

| | | | | | |
|---------------------|--|--------------|-----------|-----|----|
| Turn-On Delay Time | $(V_{DD} = 25 \text{ V}, I_D = 0.5 \text{ Rated } I_D$ $R_{gen} = 50 \text{ ohms}$ See Figures 13 and 14 | $t_{d(on)}$ | — | 70 | ns |
| Rise Time | | t_r | — | 160 | |
| Turn-Off Delay Time | | $t_{d(off)}$ | — | 430 | |
| Fall Time | | t_f | — | 200 | |
| Total Gate Charge | $(V_{DS} = 0.8 \text{ Rated } V_{DSS},$ $I_D = \text{Rated } I_D, V_{GS} = 10 \text{ V}$ See Figure 12 | Q_g | 127 (Typ) | 150 | nC |
| Gate-Source Charge | | Q_{gs} | 62 (Typ) | — | |
| Gate-Drain Charge | | Q_{gd} | 65 (Typ) | — | |

SOURCE DRAIN DIODE CHARACTERISTICS*

| | | | | | |
|-----------------------|---|----------|-----------------------------|---|-----|
| Forward On-Voltage | $(I_S = \text{Rated } I_D$ $V_{GS} = 0)$ | V_{SD} | 1.2 (Typ) | 2 | Vdc |
| Forward Turn-On Time | | t_{on} | Limited by stray inductance | | |
| Reverse Recovery Time | | t_{rr} | 500 (Typ) | — | ns |

INTERNAL PACKAGE INDUCTANCE (TO-204)

| | | | | |
|--|-------|------------|---|----|
| Internal Drain Inductance (Measured from the contact screw on the header closer to the source pin and the center of the die) | L_d | 5 (Typ) | — | nH |
| Internal Source Inductance (Measured from the source pin, 0.25" from the package to the source bond pad) | L_s | 12.5 (Typ) | — | |

INTERNAL PACKAGE INDUCTANCE (TO-218)

| | | | | |
|--|-------|--------------------|--------|----|
| Internal Drain Inductance (Measured from screw on tab to center of die) (Measured from the drain lead 0.25" from package to center of die) | L_d | 4 (Typ) 5 (Typ) | — — | nH |
| Internal Source Inductance (Measured from the source lead 0.25" from package to center of die) | L_s | 10 (Typ) | — | |

*Pulse Test: Pulse Width $\leq 300 \mu\text{s}$, Duty Cycle $\leq 2\%$.

TYPICAL ELECTRICAL CHARACTERISTICS

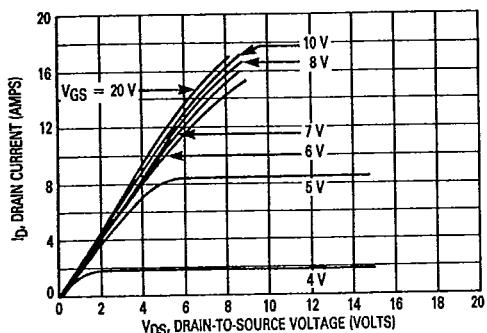


Figure 1. On-Region Characteristics

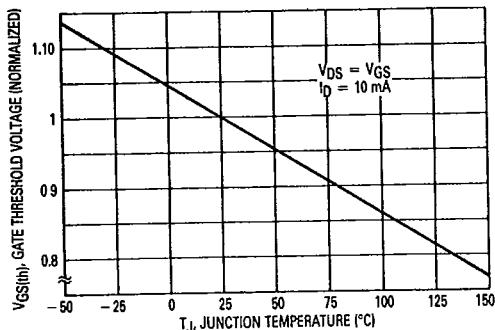


Figure 2. Gate-Threshold Voltage Variation With Temperature

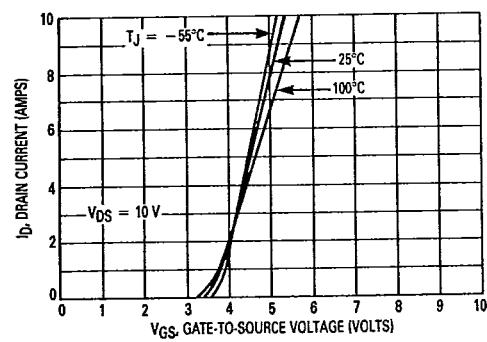


Figure 3. Transfer Characteristics

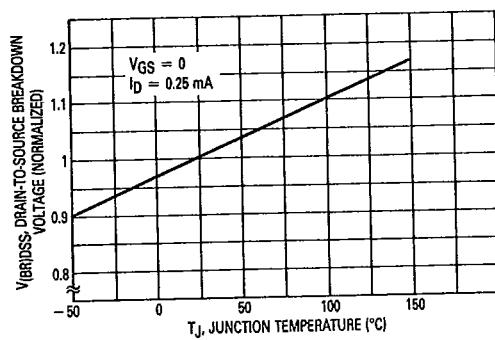


Figure 4. Breakdown Voltage Variation With Temperature

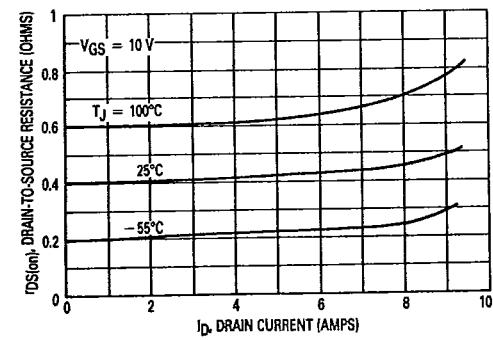


Figure 5. On-Resistance versus Drain Current

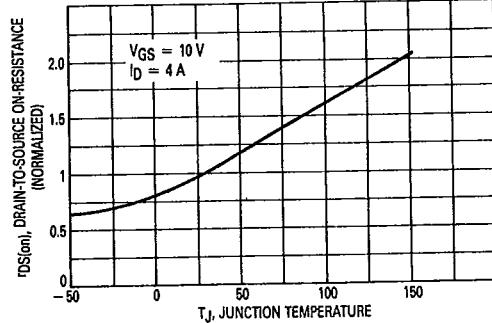


Figure 6. On-Resistance Variation With Temperature

SAFE OPERATING AREA INFORMATION

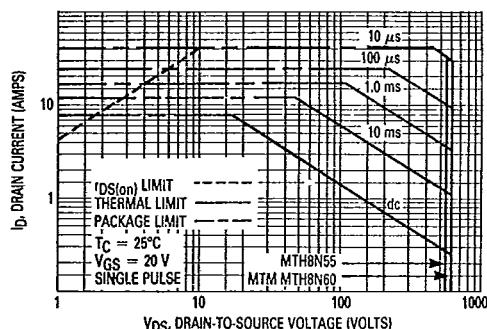


Figure 7. Maximum Rated Forward Biased Safe Operating Area

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FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola Application Note, AN569, "Transient Thermal Resistance-General Data and Its Use" provides detailed instructions.

SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 8 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current, I_{DM} and the breakdown voltage, $V_{(BR)DSS}$. The switching SOA shown in Figure 8 is applicable for both turn-on and turn-off of the devices for switching times less than one microsecond.

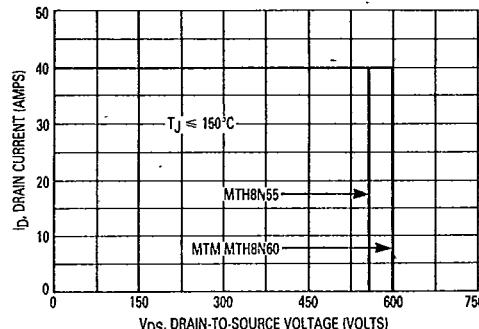


Figure 8. Maximum Rated Switching Safe Operating Area

The power averaged over a complete switching cycle must be less than:

$$\frac{T_{J(max)} - T_C}{R_{\theta JC}}$$

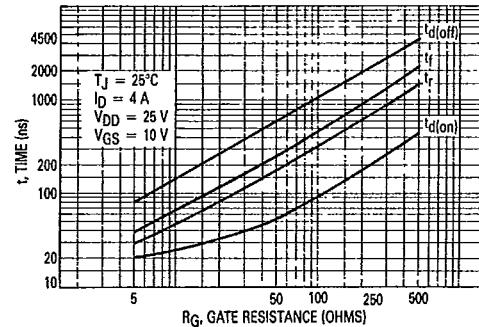


Figure 9. Resistive Switching Time Variation With Gate Resistance

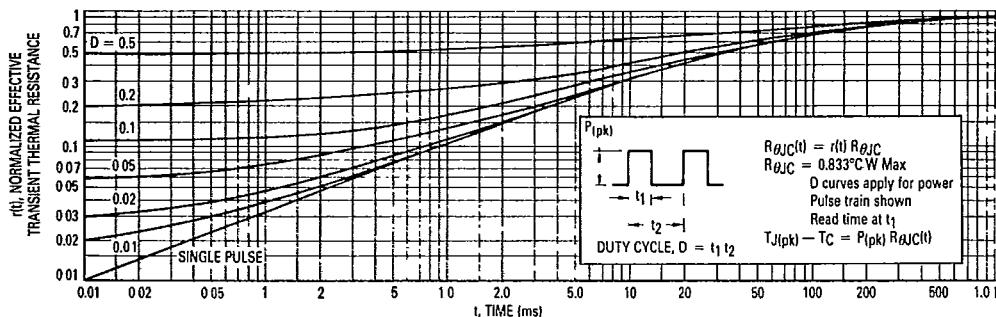


Figure 10. Thermal Response

MOTOROLA TMOS POWER MOSFET DATA

T-39-13

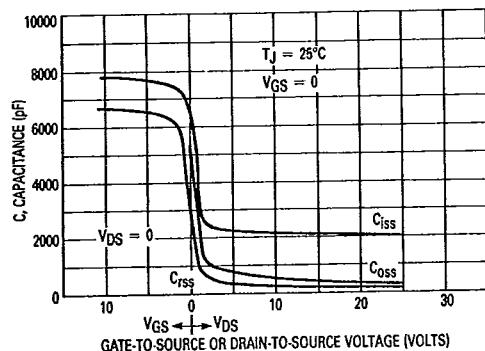


Figure 11. Capacitance Variation

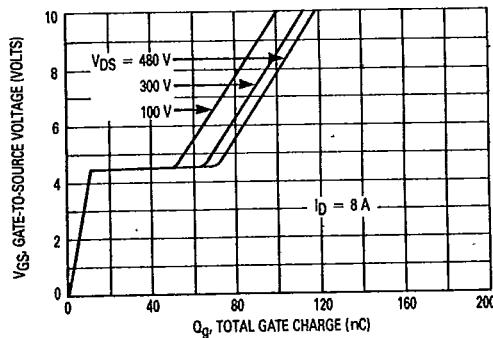


Figure 12. Gate Charge versus Gate-to-Source Voltage

RESISTIVE SWITCHING

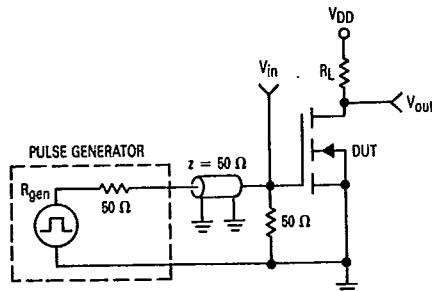


Figure 13. Switching Test Circuit

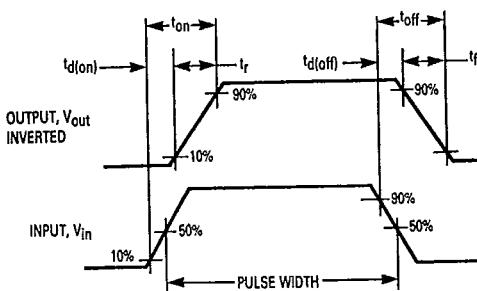
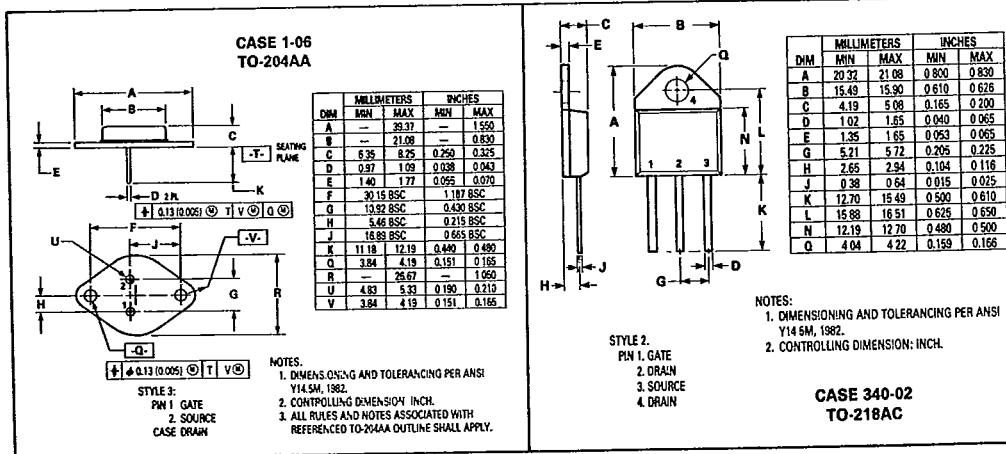


Figure 14. Switching Waveforms

OUTLINE DIMENSIONS



MOTOROLA TMOS POWER MOSFET DATA